

## Features

- Uses CRM(CQ) advanced Trench technology
- Extremely low on-resistance  $R_{DS(on)}$
- Excellent  $Q_g \times R_{DS(on)}$  product(FOM)
- Qualified according to JEDEC criteria

## Product Summary

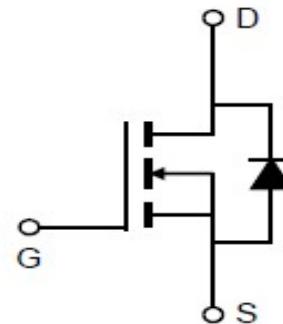
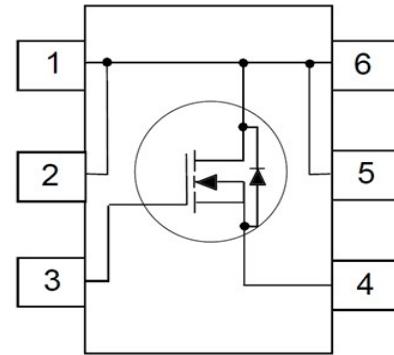
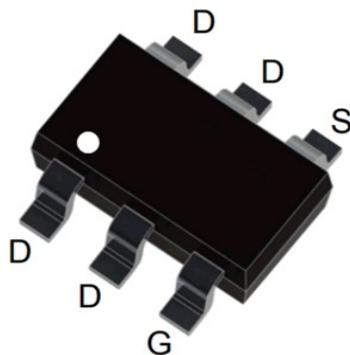
$V_{DS}$	60V
$R_{DS(on)}$ typ.	44mΩ
$I_D$	4.3A

**100% Avalanche Tested**

**100% DVDS Tested**

## Applications

- Motor control and drive
- Battery management
- UPS (Uninterruptible Power Supplies)



## Package Marking and Ordering Information

Part #	Marking	Package	Packing	Reel Size	Tape Width	Qty
CRTR550N06LZ	55006Z	TSOT23-6	Reel	N/A	N/A	3000pcs

## Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Drain-source voltage	$V_{DS}$	60	V
Continuous drain current $T_C = 25^\circ\text{C}$ (Silicon limit) $T_C = 25^\circ\text{C}$ (Package limit) $T_C = 100^\circ\text{C}$ (Silicon limit)	$I_D$	4.3 6 2.7	A
Pulsed drain current ( $T_C = 25^\circ\text{C}$ , $t_p$ limited by $T_{jmax}$ )	$I_{D\text{ pulse}}$	17	A
Avalanche energy, single pulse ( $L=0.1\text{mH}$ , $R_g=25\Omega$ )	$E_{AS}$	11	mJ
Gate-Source voltage	$V_{GS}$	$\pm 20$	V
Power dissipation ( $T_C = 25^\circ\text{C}$ )	$P_{tot}$	2	W
Operating junction and storage temperature	$T_j$ , $T_{stg}$	-55...+150	°C
Soldering temperature, wave soldering only allowed at leads (1.6mm from case for 10s)	$T_{sold}$	260	°C

**Thermal Resistance**

Parameter	Symbol	Typ	Max	Unit
Thermal resistance, junction – Lead.	R <sub>thJL</sub>	56	67	°C/W
Thermal resistance, junction – ambient(min. footprint)	R <sub>thJA</sub> *	100	140	

**Electrical Characteristic (at T<sub>j</sub> = 25 °C, unless otherwise specified)**

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		

**Static Characteristic**

Drain-source breakdown voltage	BV <sub>DSS</sub>	60	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA
Gate threshold voltage	V <sub>GS(th)</sub>	2	2.3	3	V	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA
Zero gate voltage drain current	I <sub>DSS</sub>	-	0.05	1	μA	V <sub>DS</sub> =60V, V <sub>GS</sub> =0V
		-	2	10		T <sub>j</sub> =25°C T <sub>j</sub> =150°C
Gate-source leakage current	I <sub>GSS</sub>	-	±10	±100	nA	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	44	55	mΩ	V <sub>GS</sub> =10V, I <sub>D</sub> =4.3A, T <sub>j</sub> =25°C
		-	81	100		T <sub>j</sub> =150°C
		-	48	64		V <sub>GS</sub> =6V, I <sub>D</sub> =4A,
Transconductance	g <sub>fs</sub>	-	14	-	S	V <sub>DS</sub> =10V, I <sub>D</sub> =4.3A

**Dynamic Characteristic**

Input Capacitance	C <sub>iss</sub>	-	494	889	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1MHz
Output Capacitance	C <sub>oss</sub>	-	71	135		
Reverse Transfer Capacitance	C <sub>rss</sub>	-	45	90		
Gate Total Charge	Q <sub>G</sub>	-	11.4	16.4	nC	V <sub>GS</sub> =10V, V <sub>DS</sub> =30V, I <sub>D</sub> =1A, f=1MHz
Gate-Source charge	Q <sub>gs</sub>	-	2.6	3.7		
Gate-Drain charge	Q <sub>gd</sub>	-	3.0	4.3		
Turn-on delay time	t <sub>d(on)</sub>	-	7	-	ns	V <sub>GS</sub> =10V, V <sub>DD</sub> =30V, R <sub>G_ext</sub> =6.8Ω, ID=1A
Rise time	t <sub>r</sub>	-	5	-		
Turn-off delay time	t <sub>d(off)</sub>	-	20	-		
Fall time	t <sub>f</sub>	-	23	-		
Gate resistance	R <sub>G</sub>	-	3.0	6	Ω	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz

**Body Diode Characteristic**

<b>Parameter</b>	<b>Symbol</b>	<b>Value</b>			<b>Unit</b>	<b>Test Condition</b>
		<b>min.</b>	<b>typ.</b>	<b>max.</b>		
Body Diode Forward Voltage	$V_{SD}$	-	0.9	1.3	V	$V_{GS}=0V, I_{SD}=4.3A$
Body Diode Continuous Forward Current	$I_S$			4.3	A	$T_c = 25^\circ C$
Body Diode Reverse Recovery Time	$t_{rr}$	-	22	31	ns	$I_F=4.3A, dI/dt=100A/\mu s$
Body Diode Reverse Recovery Charge	$Q_{rr}$	-	16	22	nC	

\*The value of  $R_{thJA}$  is measured by placing the device in a still air box which is one cubic foot.

## Typical Performance Characteristics

Fig 1: Output Characteristics

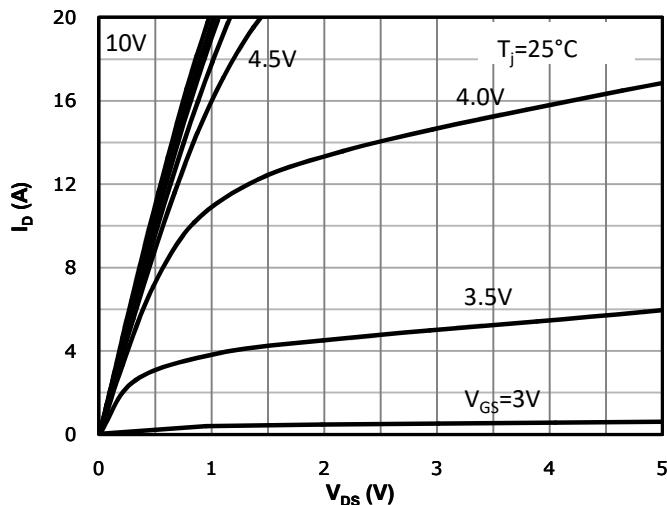


Fig 2: Transfer Characteristics

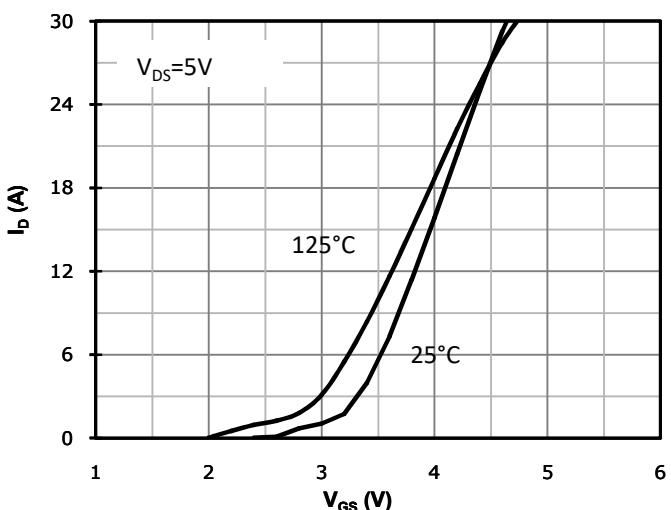
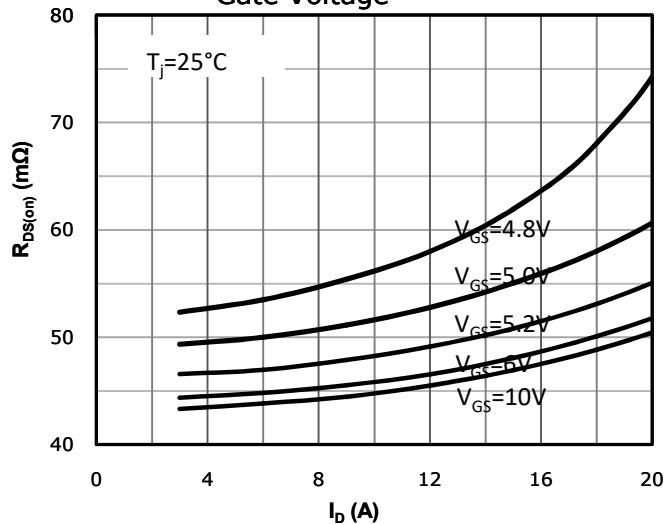
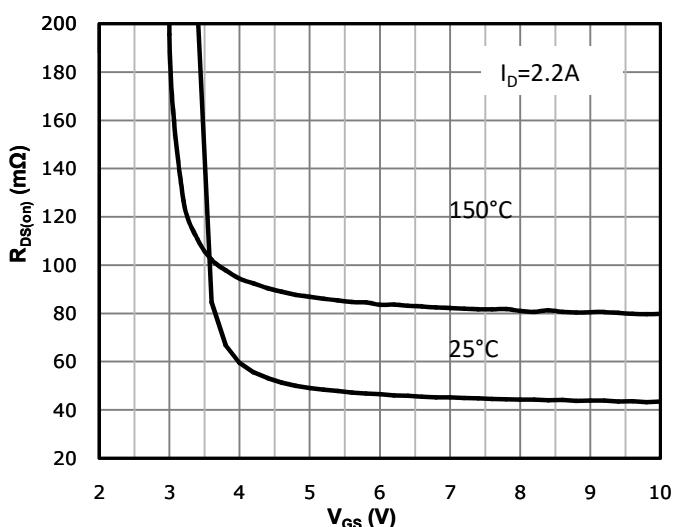
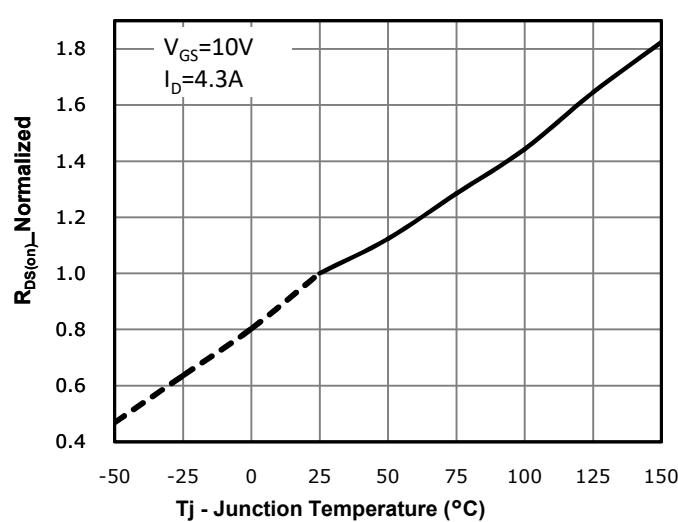

 Fig 3:  $R_{DS(on)}$  vs Drain Current and Gate Voltage

 Fig 4:  $R_{DS(on)}$  vs Gate Voltage

 Fig 5:  $R_{DS(on)}$  vs. Temperature


Fig 6: Capacitance Characteristics

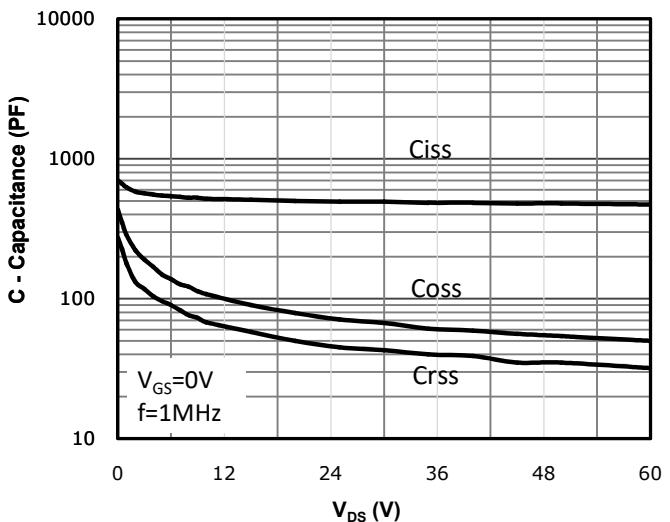


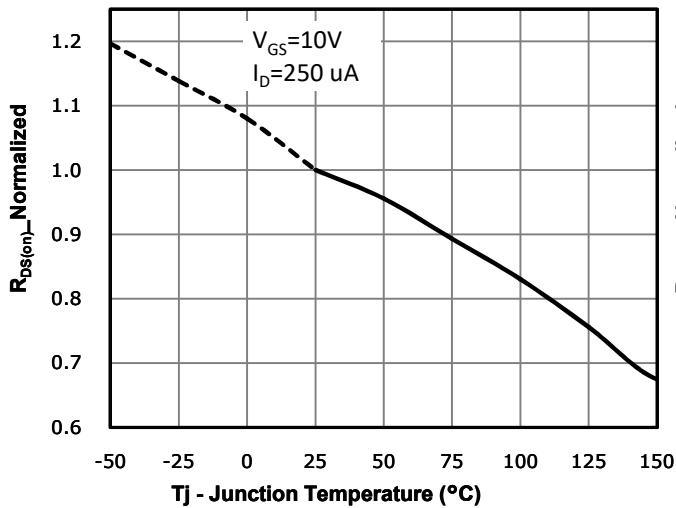
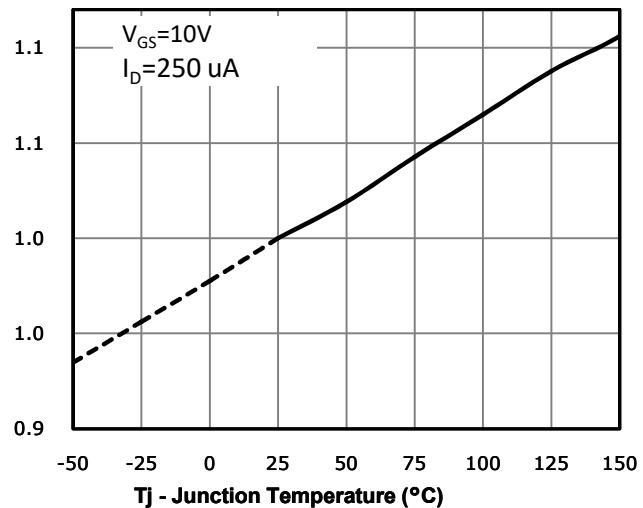
Fig 7:  $V_{th}$  vs. Temperature

 Fig 8:  $BV_{DS}$  vs. Temperature


Fig 9: Gate Charge Characteristics

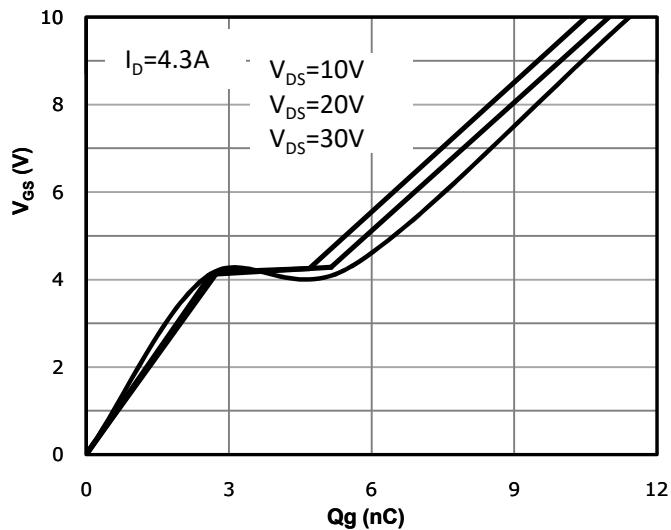


Fig 10: Body-diode Forward Characteristics

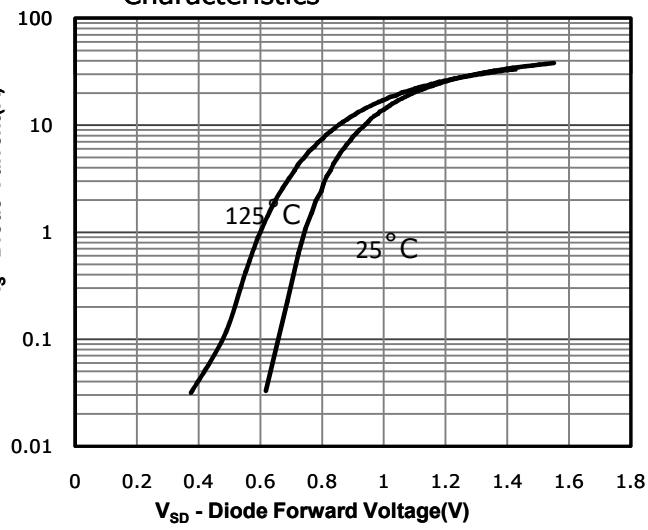


Fig 9: Power Dissipation

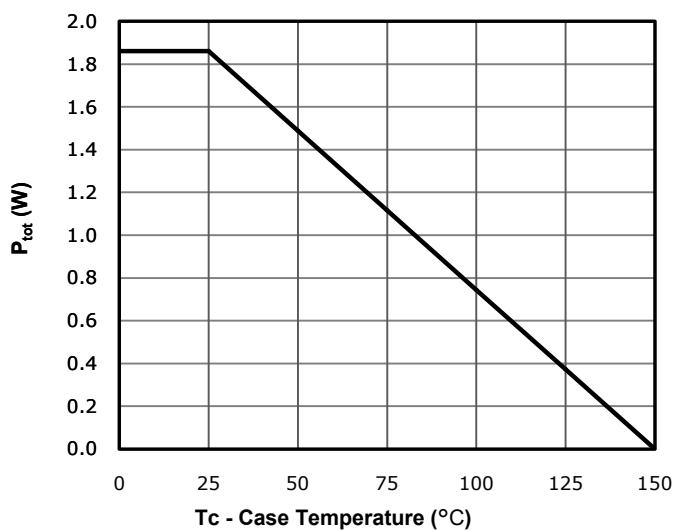


Fig 10: Drain Current Derating

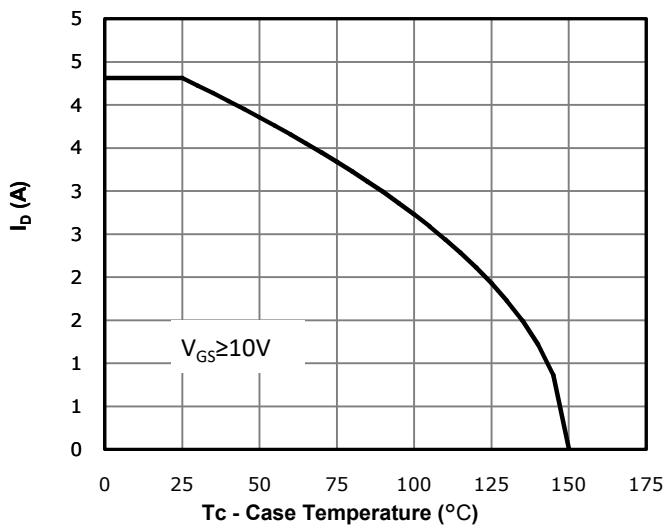


Fig 11: Safe Operating Area

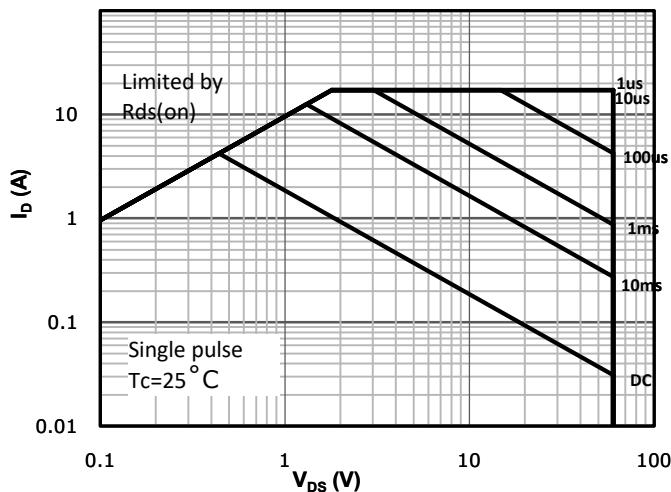
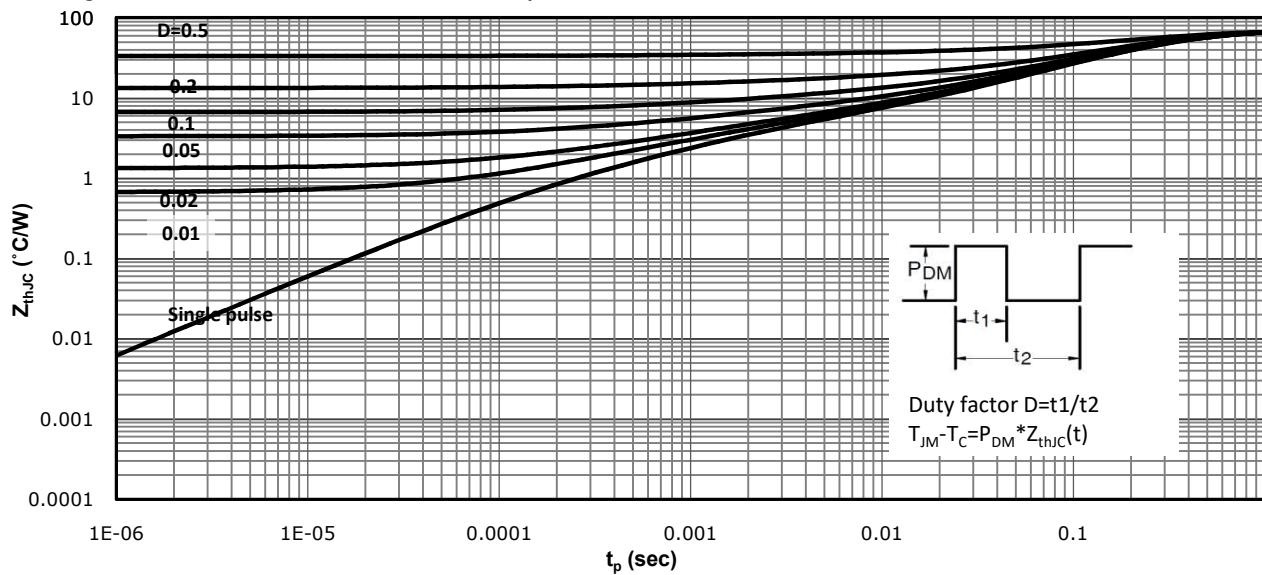
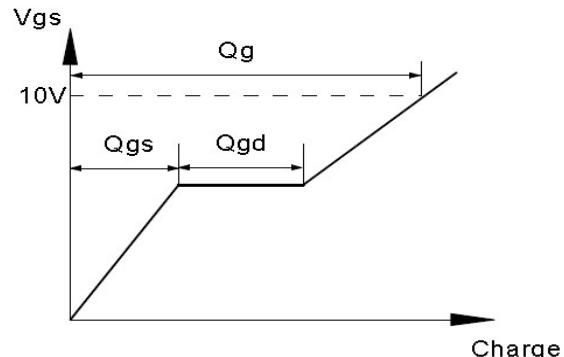
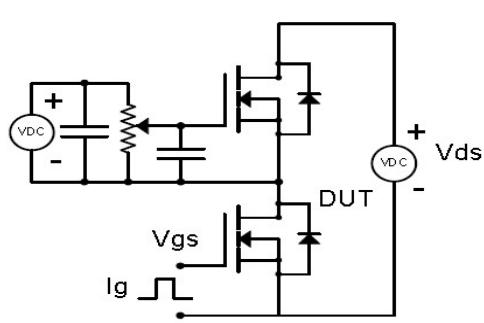


Fig 12: Max. Transient Thermal Impedance

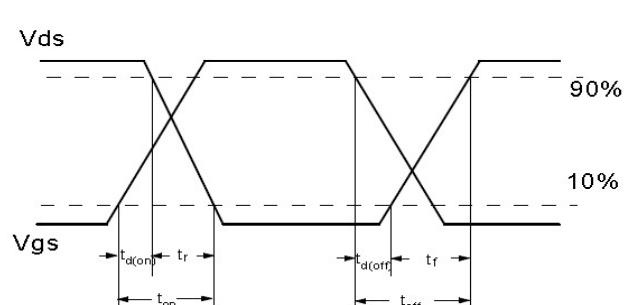
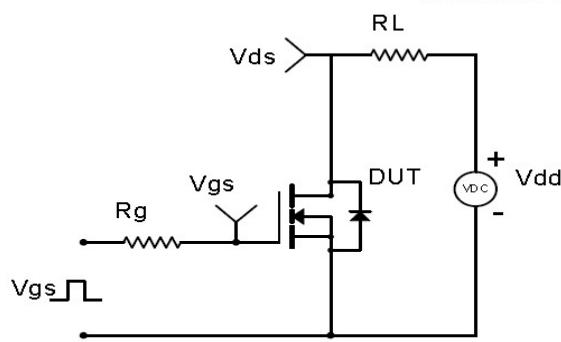


**Test Circuit & Waveform**

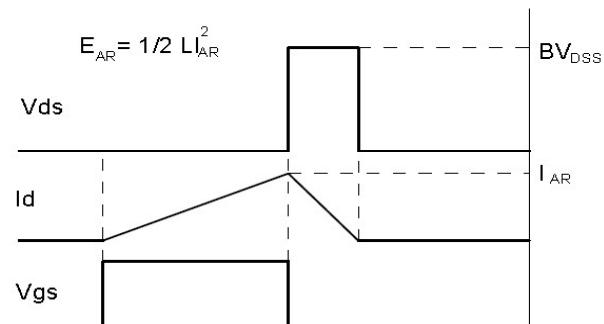
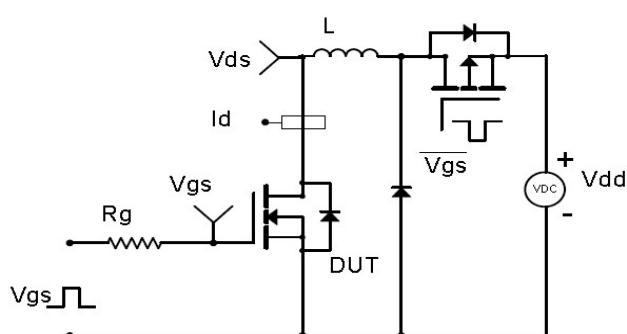
Gate Charge Test Circuit &amp; Waveform



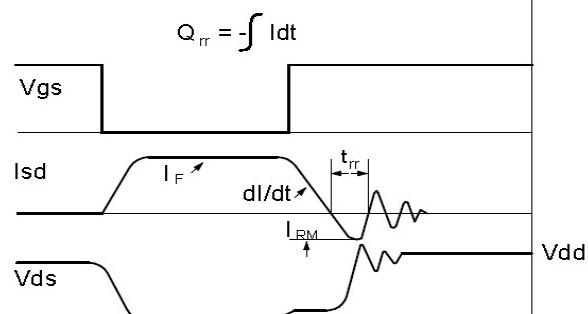
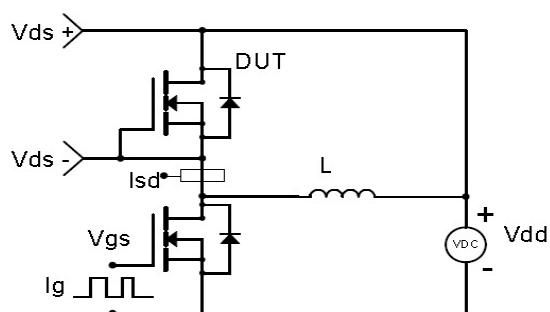
Resistive Switching Test Circuit &amp; Waveforms

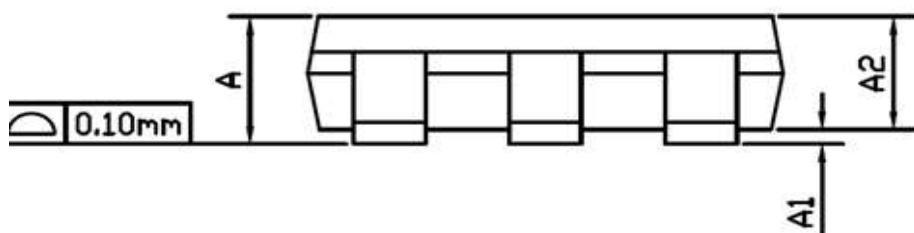
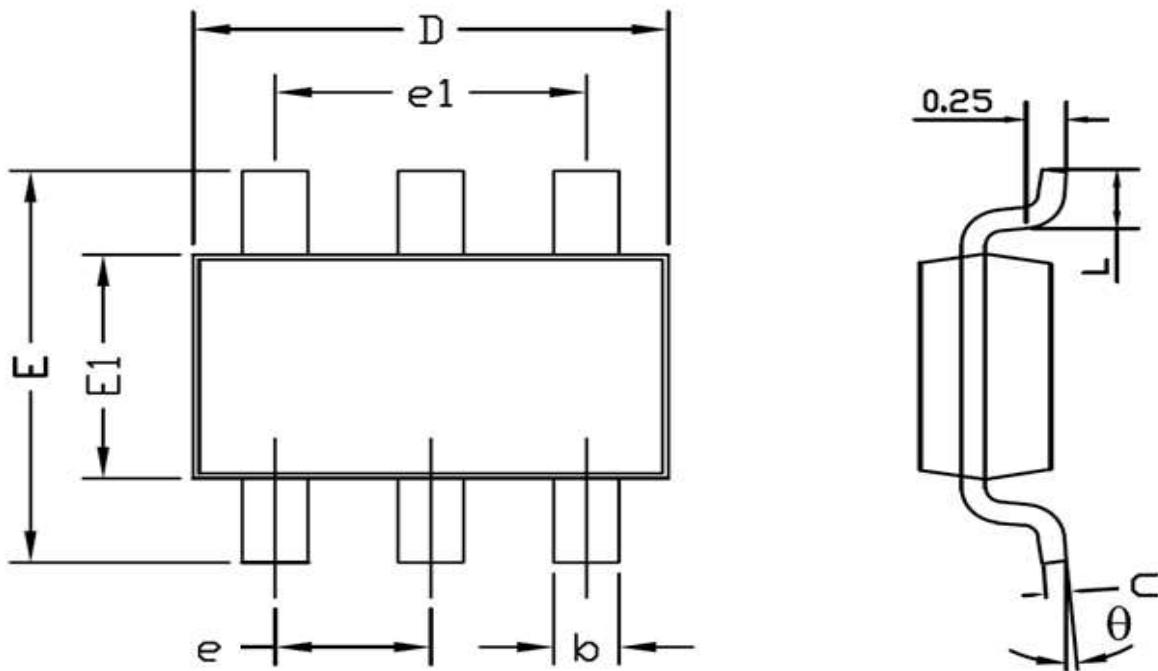


Unclamped Inductive Switching (UIS) Test Circuit &amp; Waveforms



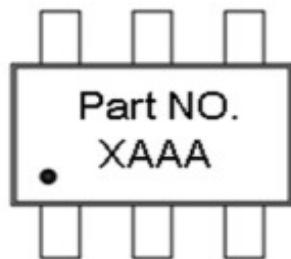
Diode Recovery Test Circuit &amp; Waveforms



**Package Outline: TSOT23-6**


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.70	0.90	0.028	0.035
A1	0.00	0.10	0.000	0.004
A2	0.70	0.85	0.028	0.033
b	0.30	0.50	0.012	0.020
c	0.08	0.20	0.003	0.008
D	2.80	3.05	0.110	0.120
e	0.95 BSC		0.037BSC	
e1	1.90 BSC		0.075 BSC	
E	2.60	3.00	0.102	0.118
E1	1.50	1.70	0.059	0.067
L	0.30	0.60	0.012	0.024
θ	0°	8°	0°	8°

## Marking



NOTE:

XAAA

X —Assembly location code

AAA —Lot code



华润微电子(重庆)有限公司

CRTR550N06LZ

Trench N-MOSFET 60V, 44mΩ, 4.3A

## Revision History

Revison	Date	Major changes
1.0	2022/9/2	Release of formal version

## Disclaimer

Unless otherwise specified in the datasheet, the product is designed and qualified as a standard commercial product and is not intended for use in applications that require extraordinary levels of quality and reliability, such as automotive, aviation/aerospace and life-support devices or systems.

Any and all semiconductor products have certain probability to fail or malfunction, which may result in personal injury, death or property damage. Customer are solely responsible for providing adequate safe measures when design their systems.

CRM(CQ) reserves the right to improve product design, function and reliability without notice.